Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination
10/729,623	DEPPISCH ET AL.
Examiner	Art Unit

Leonardo Andújar

2826

SEARCHED						
						
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
257707,712 (text search only see search notes)	7/21/2006	LA	